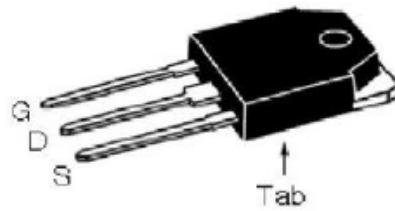
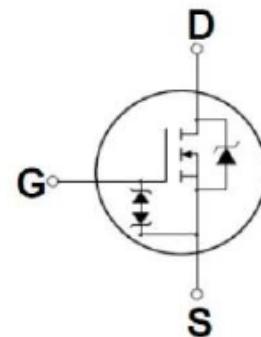


**900V N-Channel Power MOSFET****Features**

- High Voltage:  $BV_{DSS}=900V$ (Min.)
- $I_D : 9A$
- Robust high voltage termination
- Avalanche energy specified
- Improved dv/dt capability
- Low gate charge

**Application**

- Ballast Bridge
- Switch Mode Power Supplier
- Power Factor Correction
- Lighting

**Ordering Information**

Type NO	Marking	Package Code
WMQ9N90	9N90Q	TO-3P

**Absolute Maximum Ratings**(T<sub>c</sub>=25°C)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	900	V
Gate-Source Voltage	V <sub>GS</sub>	±30	V
Continuous Drain Current T <sub>c</sub> = 25 °C	I <sub>D</sub>	9	A
T <sub>c</sub> = 100 °C		5.9	A
Pulsed Drain Current (Note 1)	I <sub>DM</sub>	456	A
Single Pulse Avalanche Energy (Note 2)	E <sub>AS</sub>	201	mJ
Repetitive Avalanche Current (Note 1)	I <sub>AR</sub>	9	A
Repetitive Avalanche Energy (Note 1)	E <sub>AR</sub>	31.2	mJ
Power Dissipation T <sub>c</sub> = 25 °C	P <sub>D</sub>	312	W
Derate above 25 °C		2.5	W/°C
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55~150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T <sub>L</sub>	300	°C

\* Limited by maximum junction temperature

Parameter	Symbol	Value	Unit
Maximum Thermal resistance, Junction-to-Case	R <sub>θJC</sub>	0.4	°C/W
Maximum Thermal resistance, Junction-to-Ambient	R <sub>θJA</sub>	62.5	°C/W

\* Note: Surface mounted on FR4 board t ≤ 10sec

### Electrical Characteristics

(T<sub>c</sub>=25°C)

Parameter	Symbol	Test condition	Min	Typ	Max	Units
<b>OFF</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	900	--	--	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 900 V, V <sub>GS</sub> = 0 V	--	--	10	μA
		V <sub>DS</sub> = 720 V, T <sub>c</sub> = 125°C	--	--	100	μA
Forward Gate-Source Leakage Current	I <sub>GSSF</sub>	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	--	--	100	nA
Reverse Gate-Source Leakage Current	I <sub>GSSR</sub>	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V	--	--	-100	nA

### ON

Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2	--	4	V
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.5 A	--	1.12	1.4	Ω
Forward Transconductance <sup>(Note 4)</sup>	g <sub>F</sub>	V <sub>DS</sub> = 30 V, I <sub>D</sub> = 4.5 A	--	17	--	S

### DYNAMIC

Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	--	2740	--	pF
Output Capacitance	C <sub>oss</sub>		--	192	--	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		--	27	--	pF

### SWITCHING

Turn-On Delay Time <sup>(Note 4,5)</sup>	t <sub>d(on)</sub>	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 9 A, R <sub>G</sub> = 25 Ω	--	52	--	ns
Turn-On Rise Time <sup>(Note 4,5)</sup>	t <sub>r</sub>		--	97	--	ns
Turn-Off Delay Time <sup>(Note 4,5)</sup>	t <sub>d(off)</sub>		--	212	--	ns
Turn-Off Fall Time <sup>(Note 4,5)</sup>	t <sub>f</sub>		--	159	--	ns
Total Gate Charge <sup>(Note 4,5)</sup>	Q <sub>g</sub>	V <sub>DS</sub> = 720 V, I <sub>D</sub> = 9 A, V <sub>GS</sub> = 10 V	--	72	--	nC
Gate-Source Charge <sup>(Note 4,5)</sup>	Q <sub>gs</sub>		--	11	--	nC
Gate-Drain Charge <sup>(Note 4,5)</sup>	Q <sub>gd</sub>		--	31	--	nC

### SOURCE DRAIN DIODE

Maximum Continuous Drain-Source Diode Forward Current	I <sub>s</sub>	---	--	--	9	A
Maximum Pulsed Drain-Source Diode Forward Current	I <sub>SM</sub>	---	--	--	38	A
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>s</sub> = 9 A	--	--	1.5	V
Reverse Recovery Time <sup>(Note 4)</sup>	t <sub>rr</sub>	V <sub>GS</sub> = 0 V, I <sub>s</sub> = 9 A dI <sub>F</sub> / dt = 100 A/μs	--	570	--	ns
Reverse Recovery Charge <sup>(Note 4)</sup>	Q <sub>rr</sub>		--	6.6	--	μC

#### Note :

1. Repeated rating : Pulse width limited by safe operating area
2. L= 8.9mH, I<sub>AS</sub> = 8A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25Ω, Starting T<sub>J</sub>= 25 °C
3. I<sub>SD</sub> ≤ 8A, di/dt ≤ 200A/μs , V<sub>DD</sub> ≤ BV<sub>DS</sub>, Starting T<sub>J</sub>= 25 °C
4. Pulse Test :Pulse width ≤ 300μs, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

## Electrical Characteristic Curves

Fig. 1 Output Characteristics

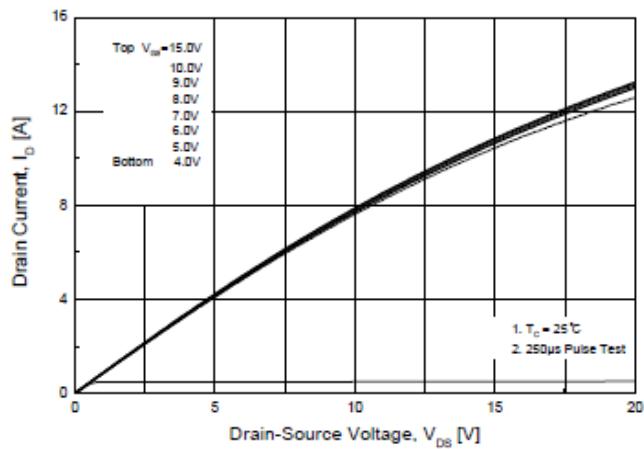


Fig. 2 Transfer Characteristics

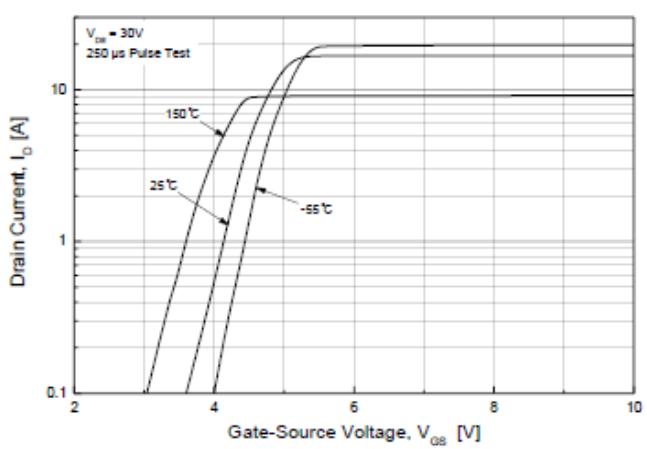


Fig. 3 On-Resistance vs.  
Drain Current and Gate voltage

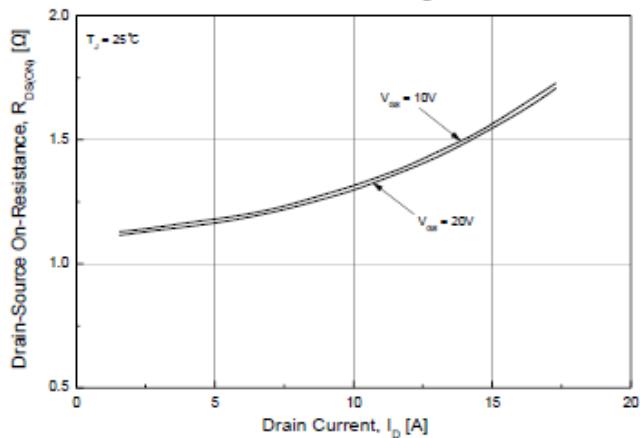


Fig. 4 Body Diode Forward Voltage vs.  
Source Current and Temperature

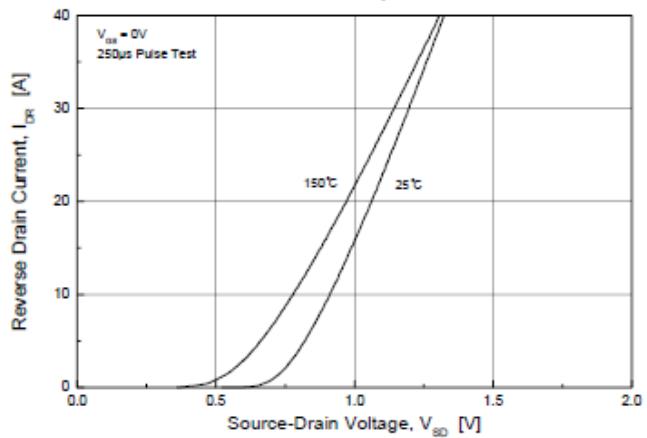


Fig. 5 Capacitance Characteristics

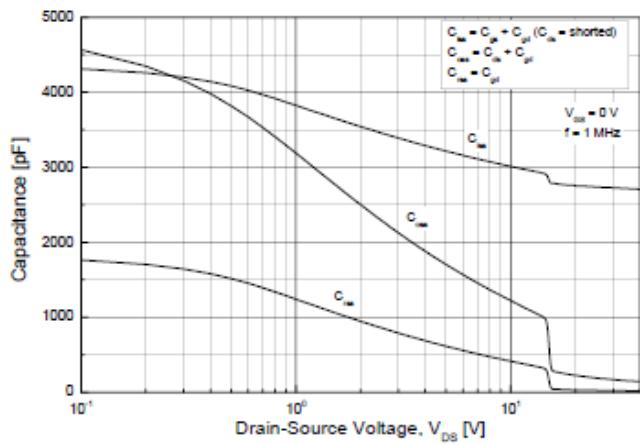


Fig. 6 Gate Charge Characteristics

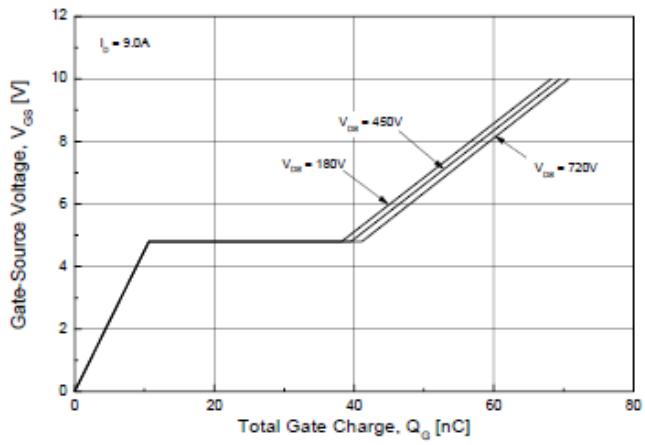


Fig. 7 Breakdown Voltage vs. Temperature

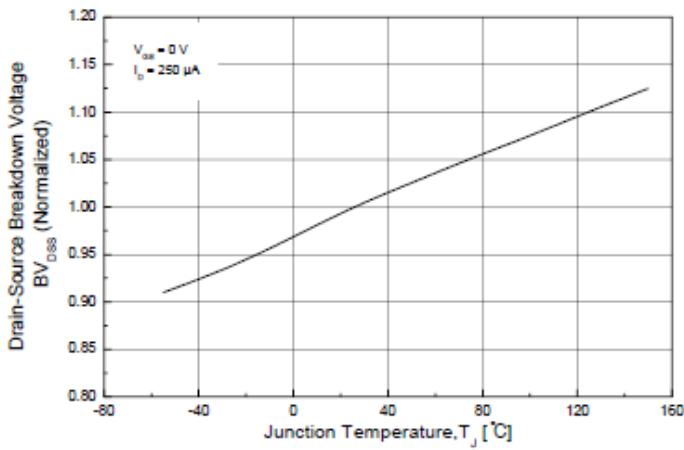


Fig. 8 On-Resistance vs. Temperature

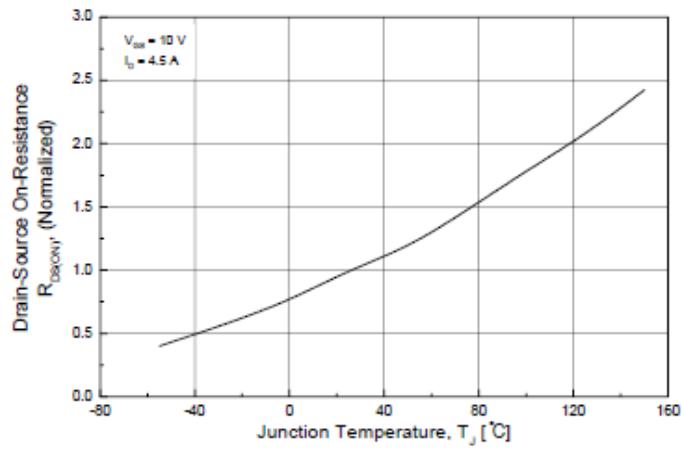


Fig. 9 Maximum Drain Current vs. Case Temperature

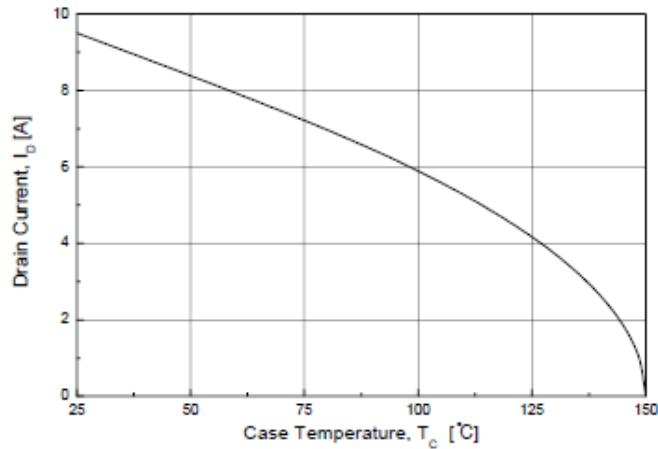


Fig. 10 Gate Threshold Voltage vs. Junction Temperature

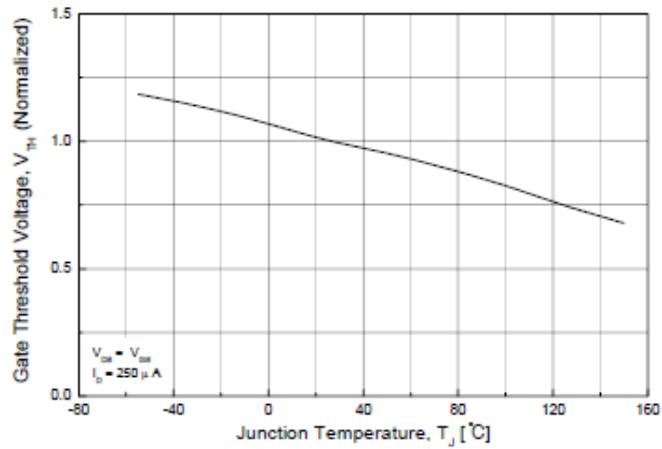


Fig. 11 Maximum Safe Operating Area

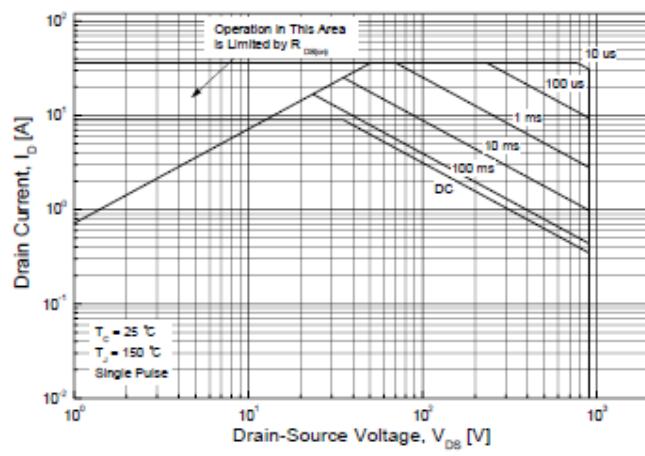
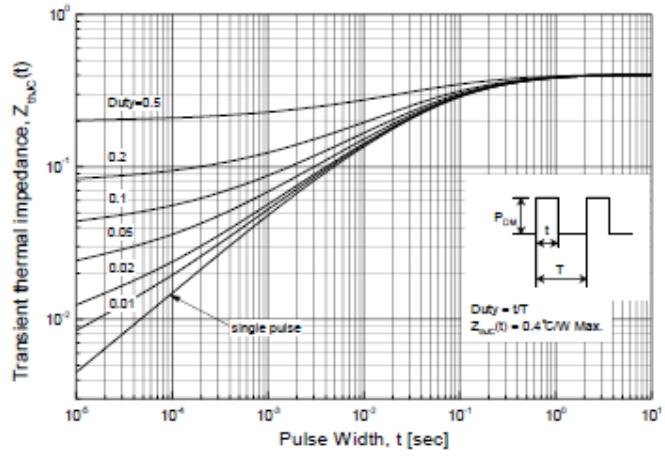
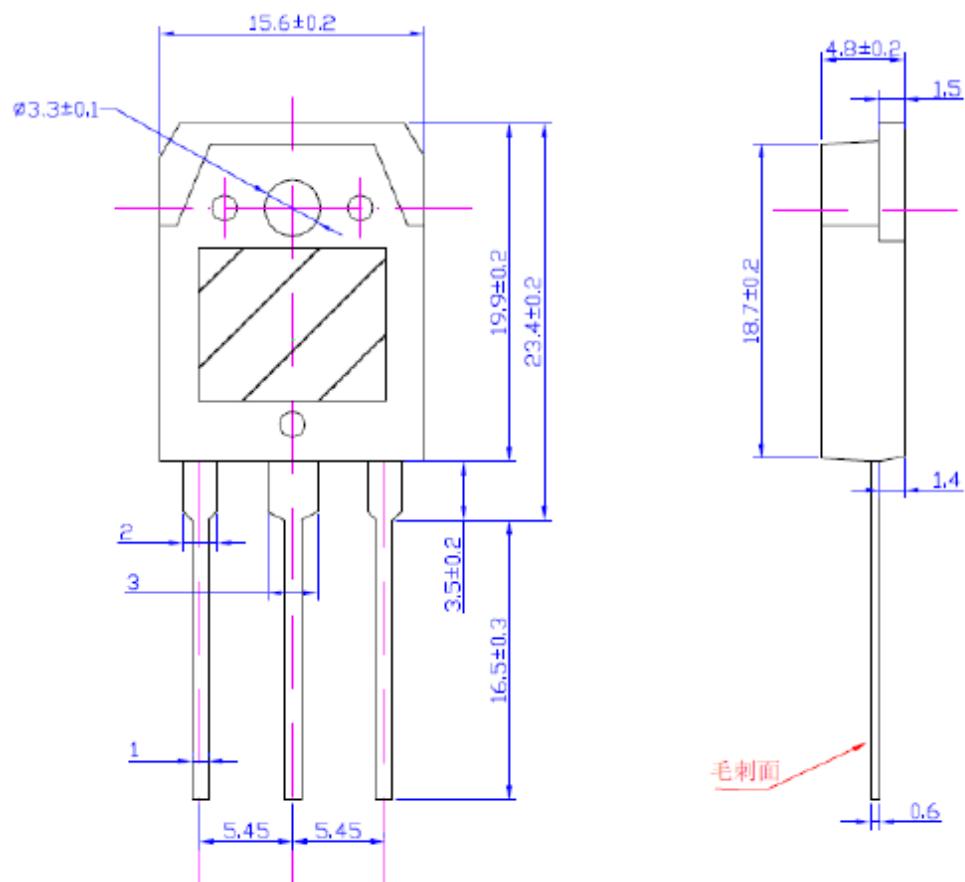


Fig. 12 Transient Thermal Response Curve



**Outline Dimension : TO-3P****Unit : mm**

**Ordering Information**

Type NO	Marking	Package Code
WMQ9N90	9N90Q	TO-3P

**Marking and Pin Define**

First Line	WTC	Company Name	
Second Line	9N90Q	Product Code	
Third Line <u>B B 0 M Q</u>	1st (Year Code)	A-2010 B-2011 C-2012 D-2013 ...	
	2nd (Month Code)	A-Jan, B-Feb, C-Mar, D-Apr, E-May, F-Jun, G-Jul, H-Aug, I-Sep, J-Oct, K-Nov, L-Dec	
	3rd (Lot Code)	0~9, A~Z	
	4th (Product Code)	M - MOS, T - Transistor, L - Linear	
	5th (Package Code)	I - TO251, D - TO252, L - TO92, M - TO126, X - TO220, F - TO220F, Y - SOT89, S - SOP8 Q - TO3P	
	6th (Spec Code)	(Reserve)	